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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/787,413	02/27/2004	Yukihiro Urakawa	249344US2SDIV	4542
22850 7590 08/29/2007 OBLON, SPIVAK, MCCLELLAND, MAIER & NEUSTADT, P.C.			EXAMINER	
1940 DUKE STREET		QUINTO, KEVIN V		
ALEXANDRIA	A, VA 22314		ART UNIT PAPER NUMBER	
			2826	
			NOTIFICATION DATE	DELIVERY MODE
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Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Notice of the Office communication was sent electronically on above-indicated "Notification Date" to the following e-mail address(es):

patentdocket@oblon.com oblonpat@oblon.com jgardner@oblon.com

	•	Application No.	Applicant(s)				
Office Action Summary		10/787,413	URAKAWA, YUKIHIRO				
		Examiner	Art Unit				
		Kevin Quinto	2826				
The MAILIN	IG DATE of this communication app	ears on the cover sheet with the	correspondence address				
WHICHEVER IS L - Extensions of time may after SIX (6) MONTHS - If NO period for reply is - Failure to reply within the Any reply received by the	CTATUTORY PERIOD FOR REPLY ONGER, FROM THE MAILING DAY be available under the provisions of 37 CFR 1.13 from the mailing date of this communication. It is specified above, the maximum statutory period we set or extended period for reply will, by statute, the Office later than three months after the mailing ustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATIO 36(a). In no event, however, may a reply be till vill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	N. mely filed the mailing date of this communication. ED (35 U.S.C. § 133).				
Status							
1) Responsive	Responsive to communication(s) filed on <u>06 June 2007</u> .						
2a) This action i	2a) This action is FINAL . 2b) ⊠ This action is non-final.						
3) Since this a	3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is						
closed in ac	cordance with the practice under E	x parte Quayle, 1935 C.D. 11, 4	53 O.G. 213.				
Disposition of Claim	s						
4a) Of the at 5)⊠ Claim(s) <u>9-1</u> 6)⊠ Claim(s) <u>1,2</u> 7)⊠ Claim(s) <u>3,7</u>	 4) Claim(s) 1-3 and 5-20 is/are pending in the application. 4a) Of the above claim(s) is/are withdrawn from consideration. 5) Claim(s) 9-15 and 17-20 is/are allowed. 6) Claim(s) 1,2,5,6 and 16 is/are rejected. 7) Claim(s) 3,7 and 8 is/are objected to. 8) Claim(s) are subject to restriction and/or election requirement. 						
Application Papers	•	•					
10)∭ The drawing Applicant ma Replacement	ation is objected to by the Examiner (s) filed on is/are: a) access of not request that any objection to the order drawing sheet(s) including the correction declaration is objected to by the Examiner	epted or b) objected to by the drawing(s) be held in abeyance. Se on is required if the drawing(s) is ob	e 37 CFR 1.85(a). jected to. See 37 CFR 1.121(d).				
Priority under 35 U.S	.C. § 119	·					
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 							
			•				
	n's Patent Drawing Review (PTO-948) e Statement(s) (PTO/SB/08)	4) Interview Summary Paper No(s)/Mail D 5) Notice of Informal F 6) Other:	ate				

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DETAILED ACTION

Response to Arguments

- 1. Applicant's arguments with respect to claims 1-3, 5-8, and 16 have been considered but are moot in view of the new ground(s) of rejection.
- 2. The examiner notes newly amended claims 16 and 17 and thus hereby withdraws the objection made to these claims in the previous Office action.

Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. Claims 1, 2, 5, 6, and 16 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yoshida (JP 4-364063 A) in view of Natsume et al. (USPN 5,477,062) and further in view of Dasse et al. (USPN 5,399,505).
- In reference to claims 1 and 16, Yoshida (JP 4-364063 A) discloses a structure which meets the claim. Figures 1 and 2 of Yoshida disclose an SiP (system in package) device comprising a chip on chip (COC) device having a logic chip (105) having a logic circuit and a memory chip (101) mounted on the logic chip (105). The memory chip (101) comprises basic chips (104) functioning as a chip independently from each other. A dicing line is interposed between the basic chips (104), connects the basic chips

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(104), and configures a part of the memory chip (101). A bump (106) connects the logic chip (105) and the memory chip (101). Although not shown, it is understood that a package covers the COC device. Yoshida does not disclose the use of a test element group in the dicing or scribing line. However the use of a test element group in the dicing or scribing line is well known in the art. Natsume et al. (USPN 5,477,062, hereinafter referred to as the "Natsume" reference) discloses that test element groups in the dicing or scribing line allow for performance testing of basic elements (column 1, lines 13-19). Dasse et al. (USPN 5,399,505, hereinafter referred to as the "Dasse" reference) discloses that testing is needed in order to determine whether or not a die is functional and that a known goal in the art is to detect and screen out defective circuitry as early as possible during the manufacturing process (column 1, lines 12-59). In view of Natsume and Dasse, it would therefore be obvious to provide a test element group the dicing or scribing line.

- 6. With regard to claim 2, it is understood that the basic chips (104) have the same layout.
- 7. With regard to claim 5, Yoshida teaches all of the claimed invention except for the square shape and exact length of the basic chip. Although Yoshida does not teach the exact square shape and length as that claimed by Applicant:

Note that the specification contains no disclosure of either the critical nature of the claimed dimensions or any unexpected results arising therefrom. Where patentability is said to be based upon particular chosen dimensions or upon another variable recited in a claim, the Applicant must show that the chosen dimensions are critical. <u>In re Woodruff</u>, 919 F.2d 1575, 1578, 16 USPQ2d 1934, 1936 (Fed. Cir. 1990).

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The shape, size, dimension differences are considered obvious design choices and are not patentable unless unobvious or unexpected results are obtained from these changes. It appears that these changes produce no functional differences and therefore would have been obvious. Note *In re* Leshin, 125 USPQ 416.

Therefore claim 5 is not patentably distinguishable over the Yoshida reference.

8. With regard to claim 6, Yoshida teaches all of the claimed invention except for the exact width of the basic chip. Although Yoshida does not teach the exact width as that claimed by Applicant:

Note that the specification contains no disclosure of either the critical nature of the claimed dimensions or any unexpected results arising therefrom. Where patentability is said to be based upon particular chosen dimensions or upon another variable recited in a claim, the Applicant must show that the chosen dimensions are critical. <u>In re Woodruff</u>, 919 F.2d 1575, 1578, 16 USPQ2d 1934, 1936 (Fed. Cir. 1990).

The shape, size, dimension differences are considered obvious design choices and are not patentable unless unobvious or unexpected results are obtained from these changes. It appears that these changes produce no functional differences and therefore would have been obvious. Note *In re* Leshin, 125 USPQ 416.

Therefore claim 6 is not patentably distinguishable over the Yoshida reference.

- 9. Claims 1, 2, 5, 6, and 16 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yoshida (JP 4-364063 A) in view of Tsuji et al. (USPN 5,716,889).
- 10. In reference to claims 1 and 16, Yoshida (JP 4-364063 A) discloses a structure which meets the claim. Figures 1 and 2 of Yoshida disclose an SiP (system in package) device comprising a chip on chip (COC) device having a logic chip (105) having a logic circuit and a memory chip (101) mounted on the logic chip (105). The memory chip (101) comprises basic chips (104) functioning as a chip independently from each other. A dicing line is interposed between the basic chips (104), connects the basic chips (104), and configures a part of the memory chip (101). A bump (106) connects the logic chip (105) and the memory chip (101). Although not shown, it is understood that a package covers the COC device. Yoshida does not disclose the use of an alignment

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mark in the dicing line. However the use of an alignment mark in the dicing line is well known in the art. Tsuji et al. (USPN 5,716,889, hereinafter referred to as the "Tsuji" reference) discloses that alignment marks in the dicing line provide alignment which is important for precise fine patterning (column 1, lines 15-39), and that precise alignment is a known goal in the art (column 1, lines 40-42). In view of Tsuji, it would therefore be obvious to provide an alignment mark in the dicing line.

- 11. With regard to claim 2, it is understood that the basic chips (104) have the same layout.
- 12. With regard to claim 5, Yoshida teaches all of the claimed invention except for the square shape and exact length of the basic chip. Although Yoshida does not teach the exact square shape and length as that claimed by Applicant:

Note that the specification contains no disclosure of either the critical nature of the claimed dimensions or any unexpected results arising therefrom. Where patentability is said to be based upon particular chosen dimensions or upon another variable recited in a claim, the Applicant must show that the chosen dimensions are critical. <u>In re Woodruff</u>, 919 F.2d 1575, 1578, 16 USPQ2d 1934, 1936 (Fed. Cir. 1990).

The shape, size, dimension differences are considered obvious design choices and are not patentable unless unobvious or unexpected results are obtained from these changes. It appears that these changes produce no functional differences and therefore would have been obvious. Note *In re* Leshin, 125 USPQ 416.

Therefore claim 5 is not patentably distinguishable over the Yoshida reference.

13. With regard to claim 6, Yoshida teaches all of the claimed invention except for the exact width of the basic chip. Although Yoshida does not teach the exact width as that claimed by Applicant:

Note that the specification contains no disclosure of either the critical nature of the claimed dimensions or any unexpected results arising therefrom. Where patentability is said to be based upon particular chosen dimensions or upon another variable recited in a claim, the Applicant must show that the chosen dimensions are critical. <u>In re Woodruff</u>, 919 F.2d 1575, 1578, 16 USPQ2d 1934, 1936 (Fed. Cir. 1990).

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The shape, size, dimension differences are considered obvious design choices and are not patentable unless unobvious or unexpected results are obtained from these changes. It appears that these changes produce no functional differences and therefore would have been obvious. Note *In re* Leshin, 125 USPQ 416.

Therefore claim 6 is not patentably distinguishable over the Yoshida reference.

Allowable Subject Matter

- 14. Claims 9-15 and 17-20 are allowed.
- 15. Claims 3, 7, and 8 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.
- 16. The following is a statement of reasons for the indication of allowable subject matter: the examiner is unaware of any prior art which suggests or renders obvious a chip on chip device formed of a memory chip mounted to a logic chip by a bump such that the memory chip contains basic chips which are connected by a dicing line where the logic chip outputs a control signal to the memory chip in order to change a specification in each basic chip.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Kevin Quinto whose telephone number is (571) 272-1920. The examiner can normally be reached on M-F 8AM-5PM.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Sue Purvis can be reached on (571) 272-1236. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

KVQ